

# PC9D10

## Ultra-high Speed Response, 2-channel OPIC Photocoupler

### ■ Features

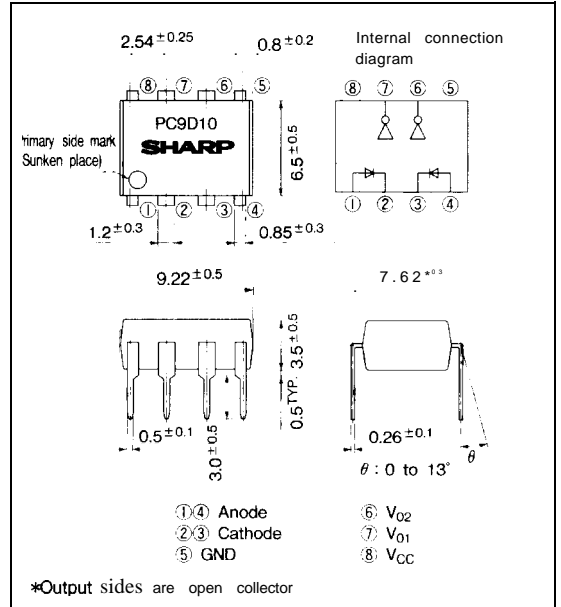
1. Built-in 2-channel
2. Ultra-high speed response  
( $t_{PHL}, t_{PLH}$ : TYP. 50ns at  $R_L = 350\Omega$ )
3. Isolation voltage between input and output  
( $V_{ISO}$ : 2 500V<sub>rms</sub>)
4. Low input current drive ( $I_{FLH}$ : MAX. 5mA)
5. Instantaneous common mode rejection  
voltage  $CM_H$ : TYP. 500V/ $\mu$ s
6. Recognized by UL. file No. 64380

### ■ Applications

1. Computer peripherals high speed interface  
for microcomputer systems
2. High speed lince receivers
3. Digital audio lince equipment
4. Interface with various data transfer equipment

### ■ Outline Dimensions

(Unit : mm)



"OPIC" (Optical IC) is a trademark of the SHARP Corporation.  
An OPIC consists of a light-detecting element and signal processing circuit integrated onto a single chip.

### ■ Absolute Maximum Ratings

(Ta = 25°C)

Parameter	Symbol	Rating	Unit
Input	*1*2 Forward current	$I_F$	15 mA
	*2 Reverse voltage	$V_R$	5 v
	*1*2 Power dissipation	$P$	40 mW
output	*1 Supply voltage	$V_{CC}$	7 v
	*2 High level output voltage	$V_{OH}$	7 v
	*2 Low level output current	$I_{OL}$	16 mA
	Collector power dissipation	$P_C$	60 mW
*4 Isolation voltage	$V_{iso}$	2 500	V <sub>rms</sub>
Operating temperature	$T_{opr}$	0 to +70	°C
Storage temperature	$T_{stg}$	-55 to +125	°C
*5 Soldering temperature	$T_{sol}$	260	°C

\*1 Ta = 0 to 70°C

\*2 Each channel

\*3 Fnr 1 minute max.

\*4 AC for 1 minute, 40 to 60%RH. Apply the specified voltage between the whole of the electrode pins on the input side and the whole of the electrode pins on the output side.

\*5 2mm or more away from the lead base for 10 seconds or less

■ **Electro-optical Characteristics**

(Unless otherwise specified, Ta = 0 to + 70°C)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX	Unit	
Input	Forward voltage	V <sub>F</sub>	Ta=25°C, I <sub>F</sub> =10mA		1.6	1.75	v	
	Reverse current	I <sub>R</sub>	Ta=25°C, V <sub>R</sub> =5V	—	—	10	μA	
	Terminal capacitance	C <sub>t</sub>	Ta=25°C, V=0, f=1MHz	—	60	250	pF	
output	High level output current	I <sub>OH</sub>	V <sub>CC</sub> =V <sub>O</sub> =5.5V, I <sub>F</sub> =250 μA	—	2	250	μA	
	Low level output voltage	V <sub>OL</sub>	V <sub>CC</sub> =5.5V, I <sub>F</sub> =5mA, I <sub>OL</sub> =13mA	—	0.4	0.6	v	
	High level supply current	I <sub>CCH</sub>	V <sub>CC</sub> =5.5V, I <sub>F</sub> =0	—	14	30	mA	
	Low level supply current	I <sub>CCL</sub>	V <sub>CC</sub> =5.5V, I <sub>F</sub> =10mA	—	26	36	mA	
Transfer characteristics	"High→Low" threshold input current	I <sub>FHL</sub>	V <sub>CC</sub> =5V, V <sub>O</sub> =0.8V, R <sub>L</sub> =350Ω	—	2.5	5	mA	
	Isolation resistance	R <sub>ISO</sub>	Ta=25°C, DC500V, 40 to 60 %RH	5 x 10 <sup>10</sup>	10 <sup>11</sup>		Ω	
	Floating capacitance	C <sub>f</sub>	Ta=25°C, V=0, f=1MHz	—	0.6	—	pF	
	Response time	High : Low propagation delay time	t <sub>PHL</sub>	Ta=25°C, V <sub>CC</sub> =5V Fig. 1	—	50	75	ns
		Low : High propagation delay time	t <sub>PLH</sub>	R <sub>L</sub> =350Ω, C <sub>L</sub> =15pF	—	50	75	ns
		Rise time, Fall time	t <sub>r</sub> , t <sub>f</sub>	I <sub>F</sub> =7.5mA	—	30	60	ns
	CMR	Instantaneous common mode rejection voltage "High level output"	CM <sub>H</sub>	Ta=25°C, V <sub>CC</sub> =5V, V <sub>OMINI</sub> =2V Fig. 2 V <sub>CM</sub> =10V, R <sub>L</sub> =350Ω, I <sub>F</sub> =0	100	500	—	V/μs
Instantaneous common mode rejection voltage "Low level output"		CM <sub>L</sub>	Ta=25°C, V <sub>CC</sub> =5V, V <sub>OMAXI</sub> =0.8V Fig. 2 V <sub>CM</sub> =10V, R <sub>L</sub> =350Ω, I <sub>F</sub> =5mA	-100	-500	—	V/μs	

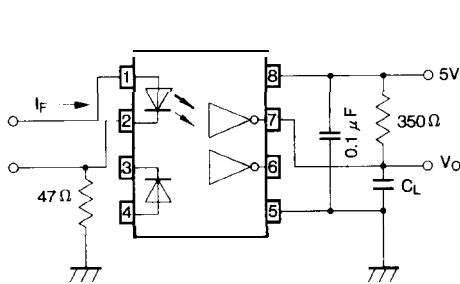
All typical values : at Ta = 25-C, Vcc=5V

■ **Recommended Operating Conditions**

Parameter	Symbol	MIN.	MAX.	Unit
Low level input current	I <sub>FL</sub>	0	250	μA
High level input current	I <sub>FH</sub>	7	15	mA
Supply voltage	V <sub>CC</sub>	4.5	5.5	v
Fanout (TTL load)	N	—	8	—
Operating temperature	T <sub>opr</sub>	0	70	°c

Connect a ceramic by-pass capacitor (0.01 to 0.1 μ F) between v<sub>cc</sub> and GND at the position within 1cm from pin.

Fig. 1 Test Circuit for t<sub>PHL</sub>, t<sub>PLH</sub>, t<sub>r</sub> and t<sub>f</sub>



\*C<sub>L</sub> includes the probe and wiring capacitance.

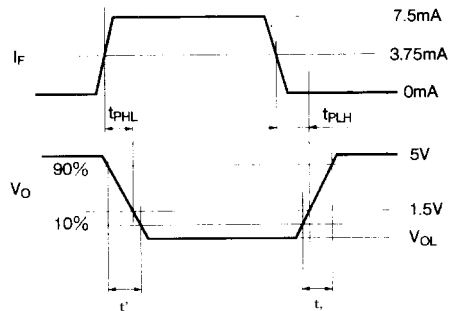


Fig. 2 Test Circuit for  $CM_H$  and  $CM_L$

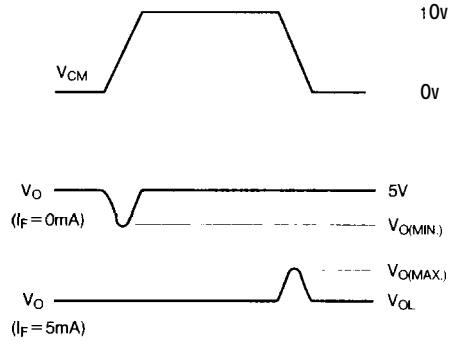
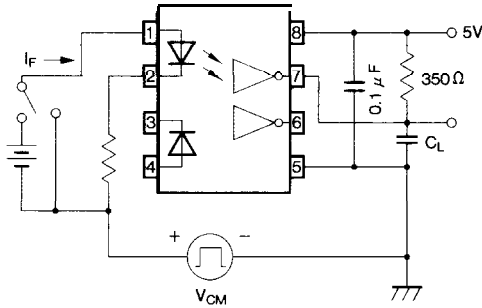


Fig. 3 Collector Power Dissipation vs. Ambient Temperature

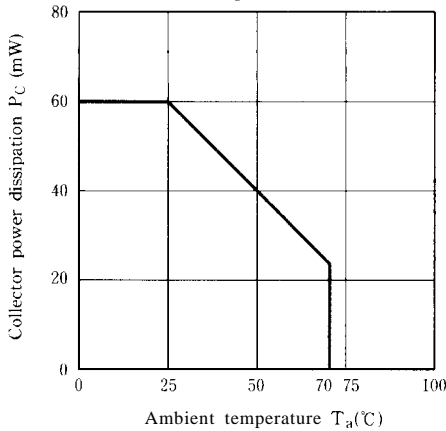


Fig. 4 Forward Current vs. Forward Voltage

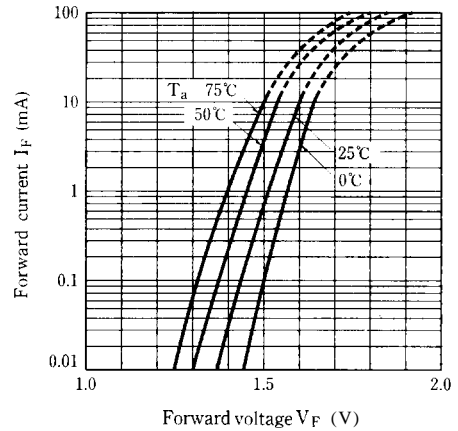


Fig. 5 High Level Output Current vs. Ambient Temperature

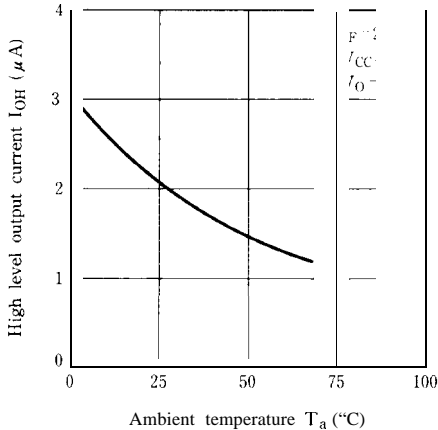


Fig. 6 Low Level Output Voltage vs. Ambient Temperature

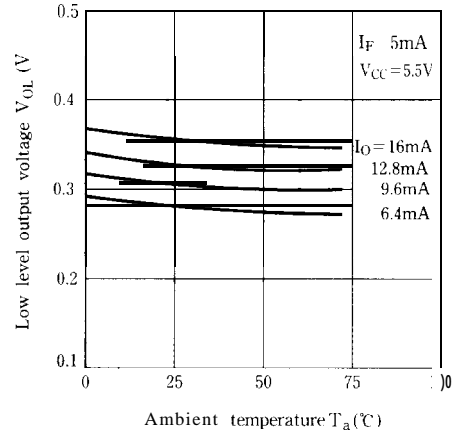


Fig. 7-a Output Voltage vs. Forward Current

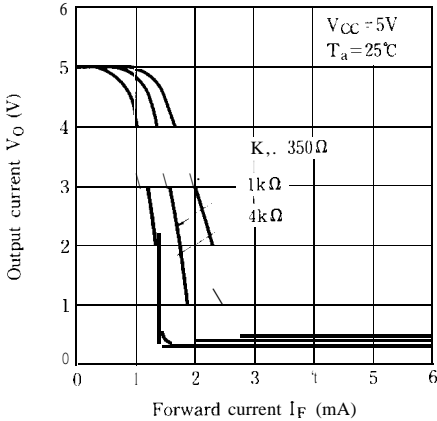


Fig. 7-b Output Voltage vs. Forward Current (Ambient Temp. Characteristics)

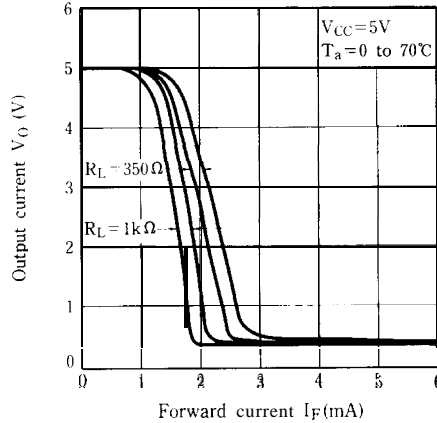


Fig. 8 Propagation Delay Time vs. Forward Current

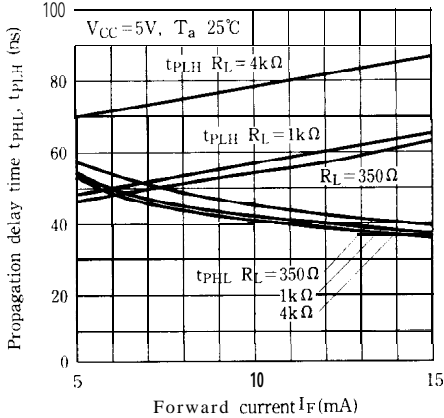


Fig. 9 Propagation Delay Time vs. Ambient Temperature

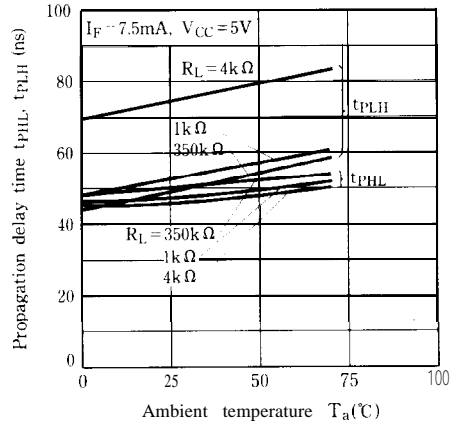
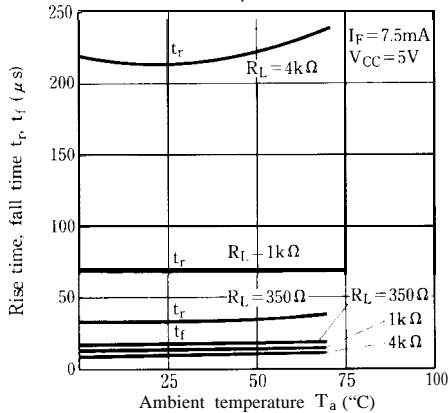


Fig. 10 Rise Time, Fall Time vs. Ambient Temperature



■ Precautions for USE

- (1) Handle this product the same as with other integrated circuits against static electricity.
- (2) As for other general cautions, refer to the chapter "Precautions for Use" (Page 78 to 93).